Notice of References Cited

	Application/Control No.	Applicant(s)/Pate	nt Under			
10/596,417		Reexamination LAM ET AL.				
	Examiner	Art Unit				
	Victor Kostak	2622	Page 1 of 1			

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,310,654	10-2001	Oku et al.	348/554
*	В	US-7,209,179	04-2007	Dai et al.	348/552
*	υ	US-7,042,511	05-2006	Lin, Tzu-Ping	348/445
*	D	US-7,034,863	04-2006	Dieterich et al.	348/184
*	Е	US-6,166,777	12-2000	Ock, Sang Soo	348/565
*	F	US-6,885,406	04-2005	Yui et al.	348/564
*	G	US-5,459,528	10-1995	Pettitt, Gregory S.	348/568
*	Н	US-5,455,632	10-1995	Ichihara, Kiyoshi	348/565
*	-	US-2002/0075407	06-2002	Cohen-Solal, Eric	348/565
*	J	US-2007/0089152	04-2007	Patten et al.	725/134
*	К	US-2005/0157948	07-2005	Lee, Janghwan	382/299
*	L	US-6,760,916	07-2004	Holtz et al.	725/34
*	М	US-2002/0140862	10-2002	Dimitrova et al.	348/565

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
Γ	v		
	w		
	x		

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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